Notice of References Cited

Application/Control No. 10/560,023	Applicant(s)/P Reexaminatio KIM ET AL.	
Examiner	Art Unit	
Erin Snelting	1791	Page 1 of 1

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	А	US-3,855,172	12-1974	ller et al.	523/223
*	В	US-4,105,426	08-1978	ller et al.	65/17.3
*	С	US-6,616,873	09-2003	Duraiswami et al.	264/44
	D	US-			
	Е	US-			
	F	US-			
	G	US-		-	
	Н	US-			
		US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

	TOTAL CONTROL OF CONTR					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р		l			
	Q		l			
	R					
	s					
	т					

NON DATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	KR 0121427 (DAE-GAP GANG) 1997-11-15 (English machine translation of foreign patent already of record on applicant's IDS of 01-18-2006). [online] [retrieved 2009-02-11]. Retreived from: Korean Patent Information Online Network.
	v	
	w	
	х	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.